Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/684,018	MEYER, GARY		
Examiner	Art Unit		
Phi D. A	3637		

SEARCHED				
Class	Subclass	Date	Examiner	
52	127.5	2/4/2006	PA	
	127.7			
	127.8			
	127.9			
	122.1			
	125.1			
	126.1			
	126.5			
	126.6			
	263			
	126.2			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH ((INCLUDING SEAR		Y)
	DATE	EXMR
Boswell Christopher 70/84, 208, 204 no cross	2/4/2006	
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